

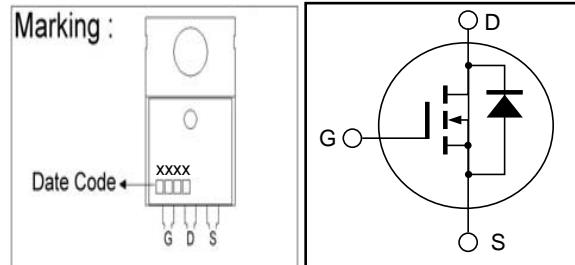
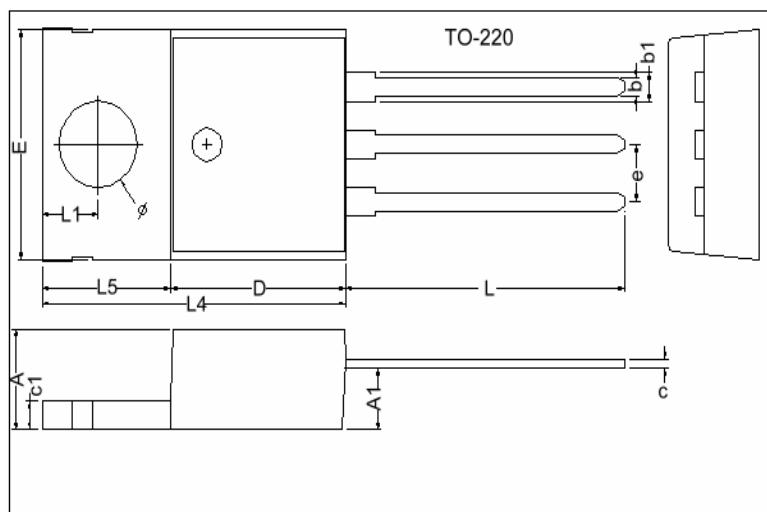
## N-Channel MOSFET

BVDSS	500V
RDS(ON)	1.2Ω
ID	5A

### Features

- \* Very Low leakage current
- \* Low gate charge
- \* Avalanche ratings
- \* High speed switching
- \* Lower  $R_{DS(ON)}$

### Package Dimensions



REF.	Millimeter		REF.	Millimeter	
	Min.	Max.		Min.	Max.
A	4.40	4.80	c1	1.25	1.45
b	0.76	1.00	b1	1.17	1.47
c	0.36	0.50	L	13.25	14.25
D	8.60	9.00	e	2.54 REF.	
E	9.80	10.4	L1	2.60	2.89
L4	14.7	15.3	Ø	3.71	3.96
L5	6.20	6.60	A1	2.60	2.80

### Absolute Maximum Ratings ( $T_a = 25^\circ\text{C}$ )

Item	Symbol	Ratings	Unit
Drain to source voltage	$V_{DSS}$	500	V
Gate to source voltage	$V_{GSS}$	$\pm 30$	V
Drain current	$I_D$	5	A
Drain peak current	$I_{D(\text{pulse})}$ <sup>Note1</sup>	20	A
Body-drain diode reverse drain current	$I_{DR}$	5	A
Body-drain diode reverse drain peak current	$I_{DR(\text{pulse})}$ <sup>Note1</sup>	20	A
Avalanche current	$I_{AP}$ <sup>Note3</sup>	5	A
Channel dissipation	$P_{ch}$ <sup>Note2</sup>	35	W
Channel to case Thermal Impedance	$\theta_{ch-c}$	4.17	$^\circ\text{C}/\text{W}$
Channel temperature	$T_{ch}$	150	$^\circ\text{C}$
Storage temperature	$T_{stg}$	-55 to +150	$^\circ\text{C}$

Note: 1. PW ≤ 10μs, duty cycle ≤ 1 %

2. Value at  $T_c = 25^\circ\text{C}$

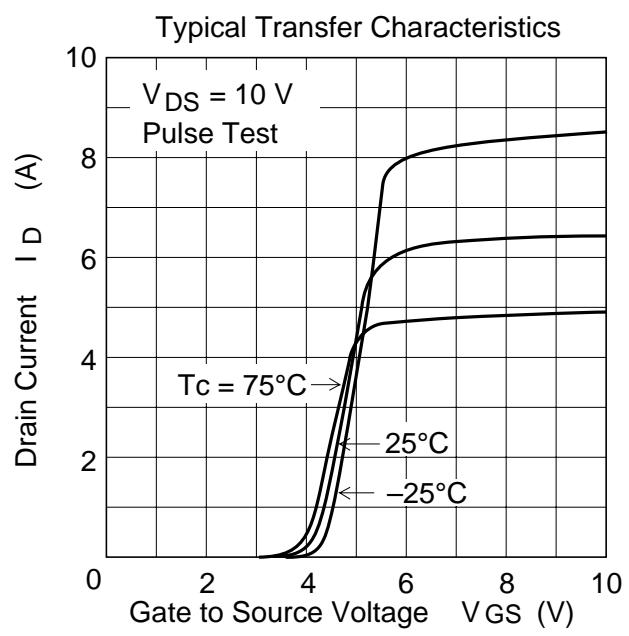
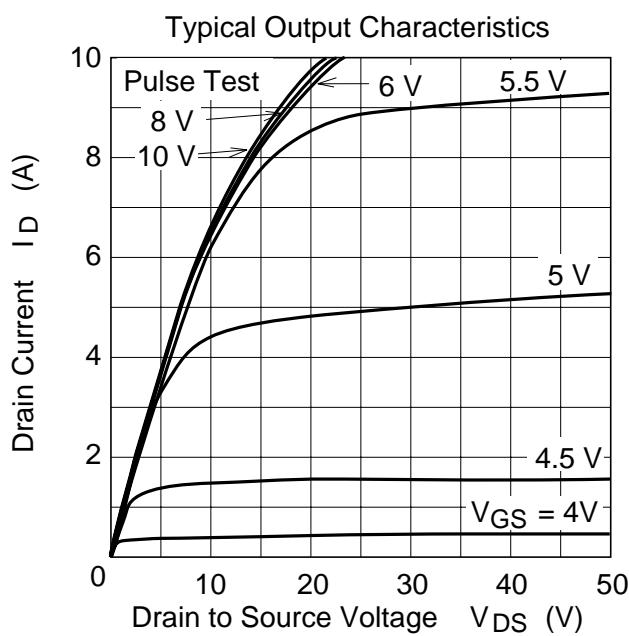
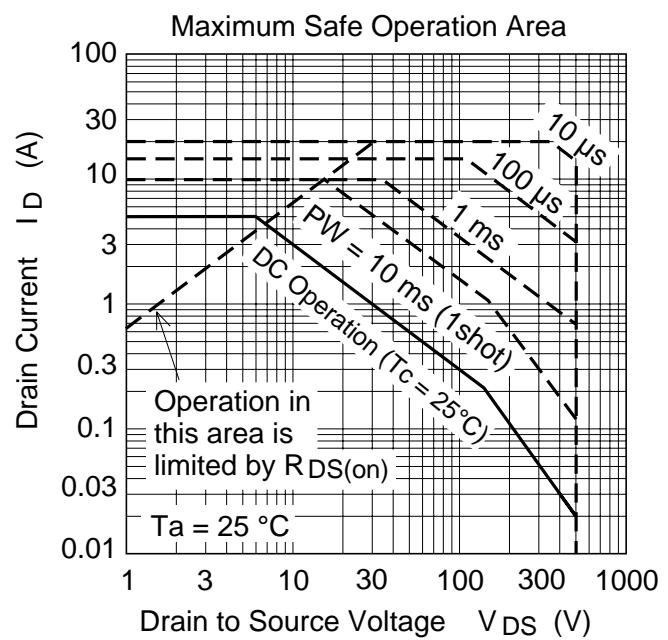
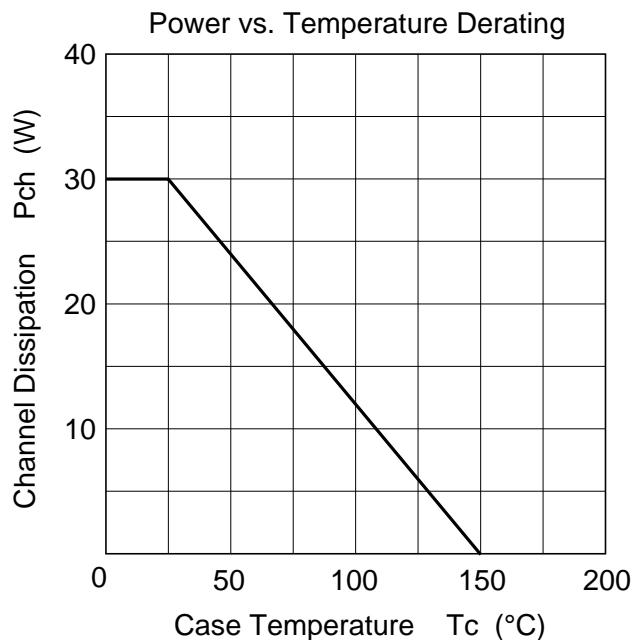
3.  $T_{ch} \leq 150^\circ\text{C}$

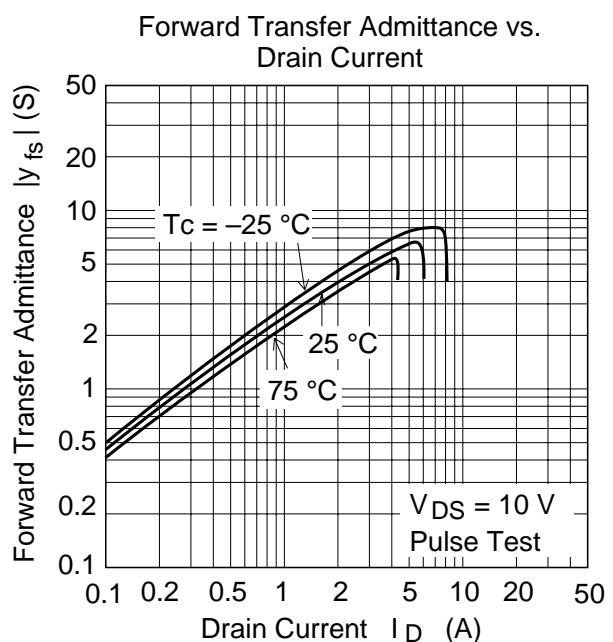
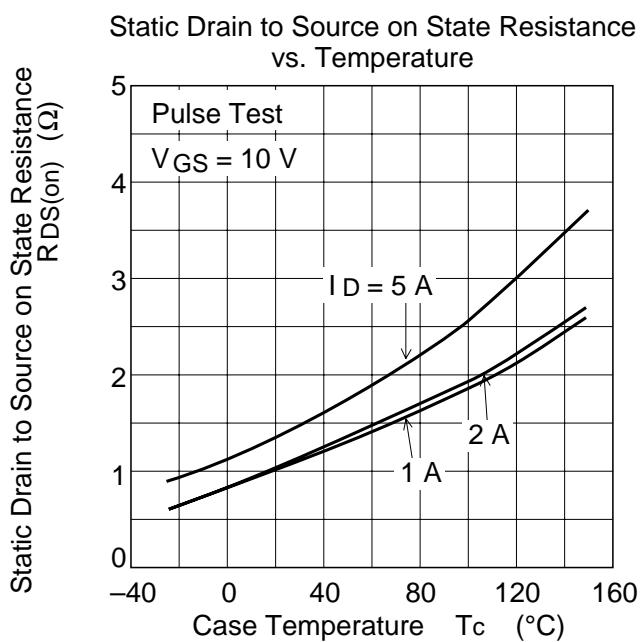
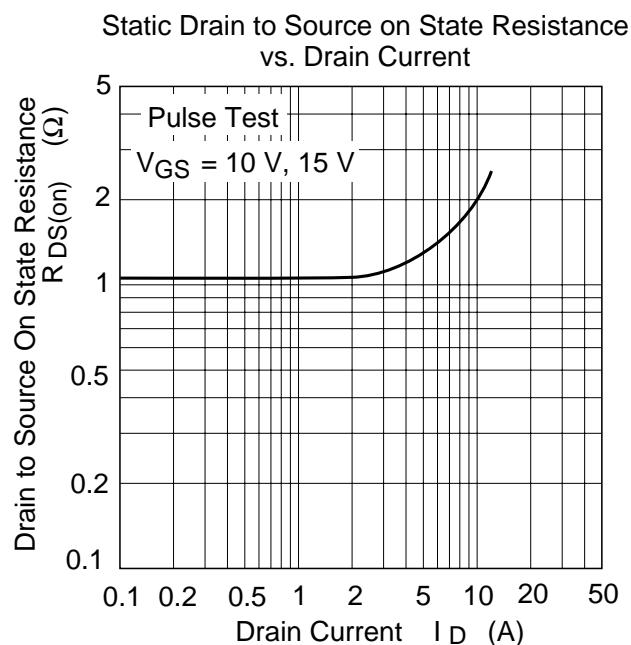
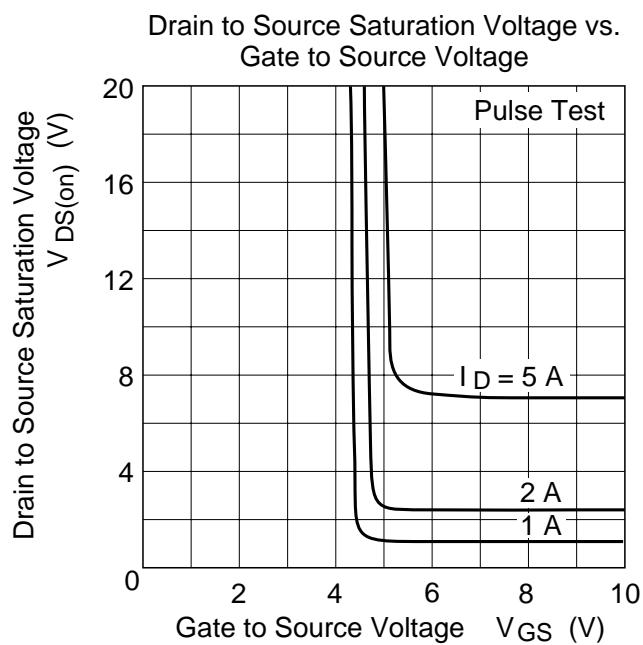
## Electrical Characteristics (Ta = 25°C)

Item	Symbol	Min	Typ	Max	Unit	Test Conditions
Drain to source breakdown voltage	V <sub>(BR)DSS</sub>	500	—	—	V	I <sub>D</sub> = 10mA, V <sub>GS</sub> = 0
Gate to source leak current	I <sub>GSS</sub>	—	—	±0.1	µA	V <sub>GS</sub> = ±30V, V <sub>DS</sub> = 0
Zero gate voltage drain current	I <sub>DSS</sub>	—	—	1	µA	V <sub>DS</sub> = 500 V, V <sub>GS</sub> = 0
Gate to source cutoff voltage	V <sub>GS(off)</sub>	3.0	—	4.0	V	I <sub>D</sub> = 1mA, V <sub>DS</sub> = 10V
Static drain to source on state resistance	R <sub>DS(on)</sub>	—	1.2	1.4	Ω	I <sub>D</sub> = 2.5A, V <sub>GS</sub> = 10V <sup>Note4</sup>
Forward transfer admittance	y <sub>fs</sub>	3.0	4.5	—	S	I <sub>D</sub> = 2.5A, V <sub>DS</sub> = 10V <sup>Note4</sup>
Input capacitance	C <sub>iss</sub>	—	580	—	pF	V <sub>DS</sub> = 25V
Output capacitance	C <sub>oss</sub>	—	70	—	pF	V <sub>GS</sub> = 0
Reverse transfer capacitance	C <sub>rss</sub>	—	13	—	pF	f = 1MHz
Turn-on delay time	t <sub>d(on)</sub>	—	20	—	ns	I <sub>D</sub> = 2.5A
Rise time	t <sub>r</sub>	—	15	—	ns	V <sub>GS</sub> = 10V
Turn-off delay time	t <sub>d(off)</sub>	—	65	—	ns	R <sub>L</sub> = 100Ω
Fall time	t <sub>f</sub>	—	15	—	ns	R <sub>g</sub> = 10Ω
Total gate charge	Q <sub>g</sub>	—	15	—	nC	V <sub>DD</sub> = 400V
Gate to source charge	Q <sub>gs</sub>	—	3	—	nC	V <sub>GS</sub> = 10V
Gate to drain charge	Q <sub>gd</sub>	—	8	—	nC	I <sub>D</sub> = 5A
Body-drain diode forward voltage	V <sub>DF</sub>	—	0.85	1.3	V	I <sub>F</sub> = 5A, V <sub>GS</sub> = 0
Body-drain diode reverse recovery time	t <sub>rr</sub>	—	400	—	ns	I <sub>F</sub> = 5A, V <sub>GS</sub> = 0 diF/dt = 100A/µs
Body-drain diode reverse recovery charge	Q <sub>rr</sub>	—	1.5	—	µC	

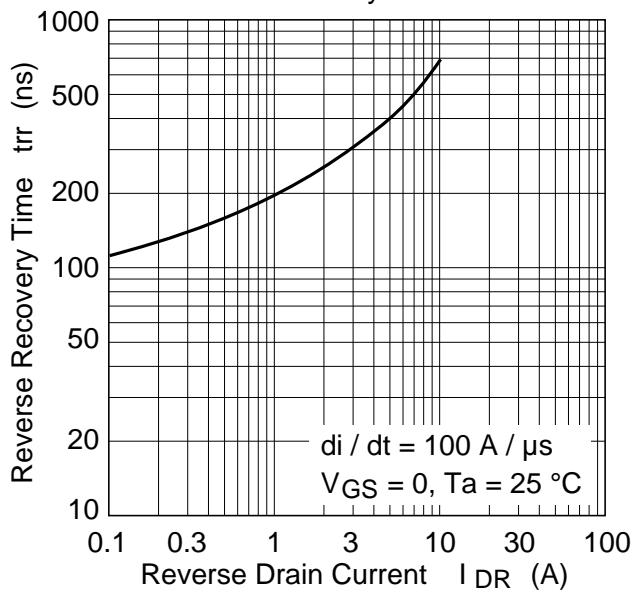
Note: 4. Pulse test

## Main Characteristics

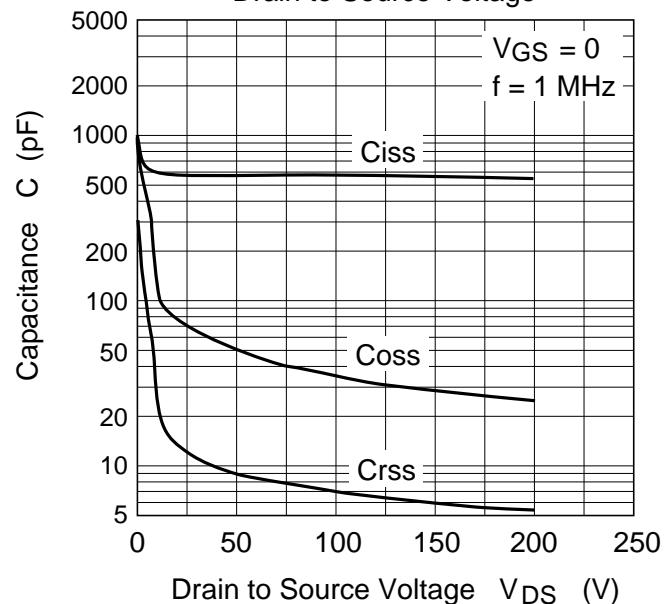




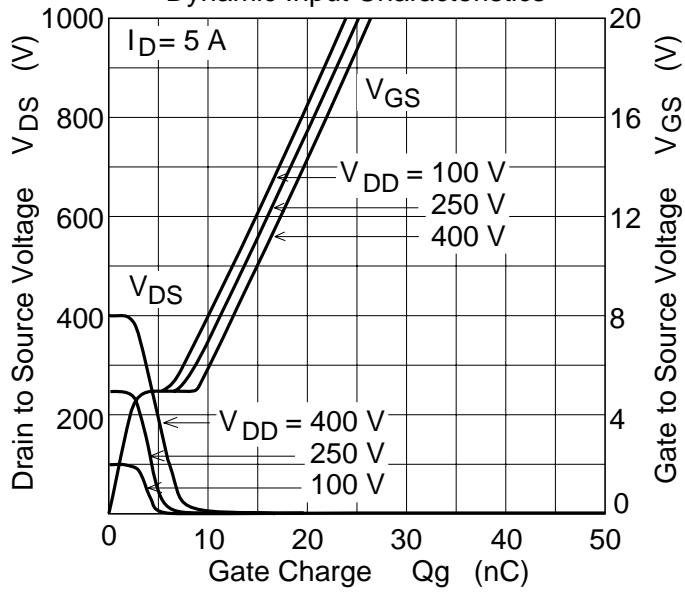
Body–Drain Diode Reverse Recovery Time



Typical Capacitance vs. Drain to Source Voltage



Dynamic Input Characteristics



Switching Characteristics

